

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









AO6405

30V P-Channel MOSFET

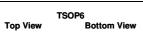
General Description

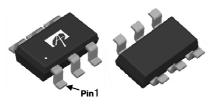
The AO6405 uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$ with low gate charge. This device is suitable for use as a load switch or in PWM applications.

Product Summary

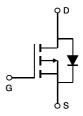
 $\begin{array}{lll} V_{DS} & -30V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & -5A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 52m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} = 4.5V) & < 87m\Omega \end{array}$











Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	-30	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain Current	T _A =25℃		-5		
	T _A =70℃	'D	-4.2	A	
Pulsed Drain Current ^c		I _{DM}	-20		
	T _A =25℃	D	2	W	
Power Dissipation B	T _A =70°C		1.3	T vv	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C.	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	47.5	62.5				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	74	110				
Maximum Junction-to-Lead Steady		$R_{\theta JL}$	37	50	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V			-1	μА			
		T _J =55℃			-5	μΑ			
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V			±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=-250\mu A$	-1.4	-1.9	-2.4	V			
$I_{D(ON)}$	On state drain current	V_{GS} =-10V, V_{DS} =-5V	-20			Α			
		V _{GS} =-10V, I _D =-5A		34	52	mΩ			
$R_{DS(ON)}$	Static Drain-Source On-Resistance	T _J =125℃		52	70	11122			
		V_{GS} =-4.5V, I_D =-4A		54	87	mΩ			
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-5A		10		S			
V_{SD}	Diode Forward Voltage	$I_S=-1A, V_{GS}=0V$		-0.7	-1	V			
I_S	Maximum Body-Diode Continuous Curr			-2.5	Α				
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance			520		pF			
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-15V, f=1MHz		100		pF			
C _{rss}	Reverse Transfer Capacitance]		65		pF			
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	3.5	7.5	11.5	Ω			
SWITCHI	NG PARAMETERS								
Q _g (10V)	Total Gate Charge			9.2	11	nC			
Q _g (4.5V)	Total Gate Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-5A		4.6	6	nC			
Q_{gs}	Gate Source Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-5A		1.6		nC			
Q_{gd}	Gate Drain Charge]		2.2		nC			
t _{D(on)}	Turn-On DelayTime			7.5		ns			
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-15V, R_L =3 Ω ,		5.5		ns			
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		19		ns			
t _f	Turn-Off Fall Time]		7		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =-5A, dI/dt=100A/μs		11		ns			
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =-5A, dI/dt=100A/μs		5.3		nC			

A. The value of $R_{\theta JA}$ is measured with the device mounted on $1 in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.i}=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

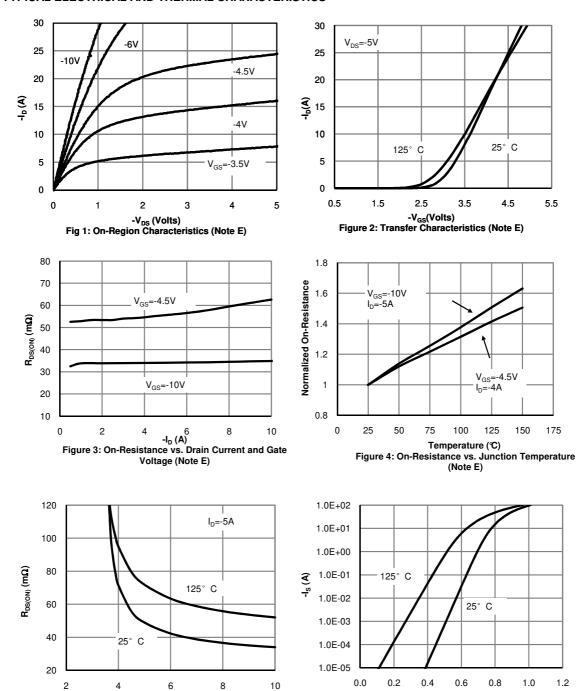
F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}=150^{\circ}$ C. The SOA curve provides a single pulse rating.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

-V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage

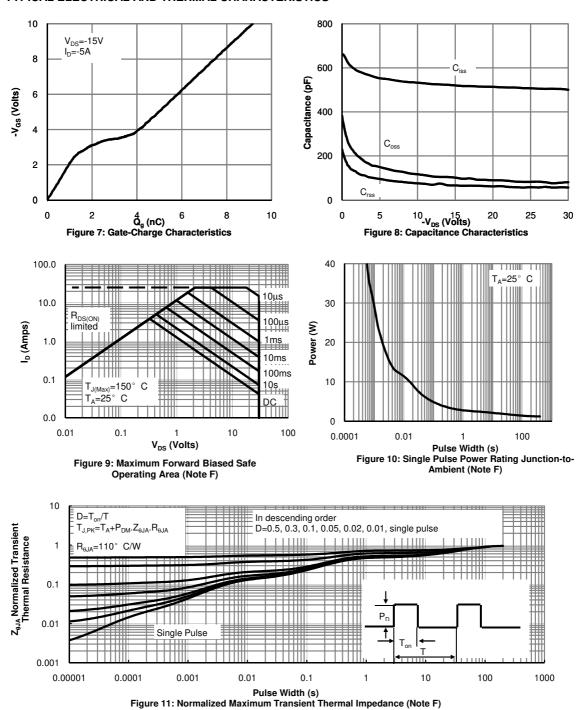
(Note E)



-V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

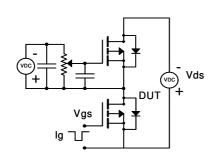


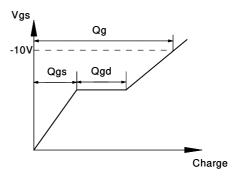
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



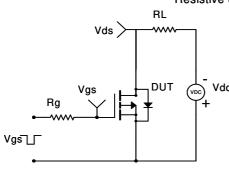


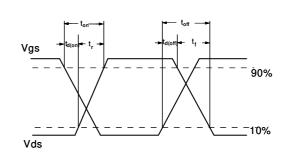
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

